THE GEORGE WASHINGTON UNIVERSITY

WASHINGTON. DC School of Engineering and Applied Science Department of Electrical and Computer Engineering ECE 2115 - LAB

Experiment # 14

CMOS Inverter, NAND, and NOR Gate Design

Equipment:

You must make up a complete equipment list and have your instructor review it before you start.

Objectives:

- To test a CMOS inverter using the 4007 MOS array chip
- To simulate a CMOS inverter using the IRF9140 and IRF150 MOS transistors in SPICE
- To design a CMOS NAND gate and a CMOS NOR gate both using 4007 MOS chip and using the IRF9140 and IRF150 MOS transistors in SPICE
- To compare propagation delays of these gates.



<u>1.- (HW)Inverter Simulation</u>

- Simulate (PSPICE) a CMOS inverter built utilizing a PMOS IRF9140 and an NMOS IRF150 for the K parameter of the p transistor (K_p) being equal to K parameter of the n transistor (K_n). Repeat the simulation for K_p= 4 K_n, K_p= 2 K_n, K_p= 0.5 K_n, and K_p= 0.25 K_n. Compare the output graphs and comment on each case. Use V_{DD}=0 Volts and V_{ss}=10Volts.
- Simulate the same circuit for the temperature values of 100K, 300K, and 500K, separately. Compare and comment on the output graphs.
- Connect 100 nf load capacitor to the output of the circuit. Simulate this circuit for $K_p = 4K_n$, $K_p = 2K_n$, $K_p = 0.5 K_n$ and $K_p = 0.25 K_n$ and measure low-to- high and high-to-low propagation delay of the inverter for each case.
- Connect one more CMOS inverter in series and measure low-to- high and high-to low propagation delay again of the first inverter in the sequence.
- Compare the values with those obtained in part (c) and comment on the load capacitance of the second inverter.



2.- Verification

Completely assemble the CMOS circuit using the 4007 MOS array chip. Place one voltmeter between the output and the ground of the circuit to measure the output voltage v_{out} . Keep V_{DD} set to 10 while you step v_{in} in 0.5 Volt increments from 0 to 4, in 0.25 Volt increments from 4 to 6 and in 0.5 Volt increments from 6 to 10.

- a) Measure the output voltage for each increment of $v_{\mbox{\tiny in}}$
- b) Measure the drain current and find the input voltage value when drain current is maximum (at this voltage value be v_m).
- c) Measure the input voltage v_{in} when it is equal to output voltage v_{out} . Check whether this value is close (or equal to) v_m measured in part b.
- d) Write a comment on the drain current vs. input voltage characteristics.

3.- CMOS Logic Gate Design (Where digital electronics begins)

- a) NAND gate design:
 - Design a NAND gate using the 4007 CMOS chip. Apply two 10Volt squarewave signals operating at different frequencies to observe the output vs. input characteristics. One frequency must be twice the value of the other.
 - Make the same design in SPICE using IRF150 and IRF9140 transistors and plot the output vs. input voltage characteristics.
 - In SPICE, connect a 100nf capacitor to the output of the NAND gate, and measure lowto-high and high-to-low propagation time delays of the NAND gate. Repeat the same experiment for 100pf, 1µf, and 10µf capacitors. What kind of relation can you observe between load capacitance and propagation delay of the gate?

b) NOR gate design:

- Design a NOR gate using the 4007 CMOS chip. Apply two 10 Volt squarewave signals operating at different frequencies to observe the output vs. input characteristics. One frequency must be twice the value of the other.
- Make the same design in SPICE using IRF150 and IRF9140 transistors and plot the output vs. input voltage characteristics.
- In SPICE, connect a 100nf capacitor to the output of the NOR gate, and measure lowto-high and high-to-low propagation time delays of the NOR gate. Repeat the same experiment for 100pf, 1µf, and 10µf capacitors. What kind of relation can you observe between load capacitance and propagation delay of the gate?
- c) Comparison:

Compare the propagation delays of NAND, NOR and Inverter gates when load capacitor is 100nF. Which one is the fastest? Why? (Bonus will be given to those who can explain the reason mathematically)